

**Search Notes**

Application/Control No.

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Examiner

DAVID Y. ENG

Applicant(s)/Patent under  
Reexamination

CHEN ET AL.

Art Unit

2155

**SEARCHED**

Class	Subclass	Date	Examiner
709	213 223 236	7/29/2007	DE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
709	213		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR